

# TEST REPORT



**CTK Co., Ltd.**  
(Ho-dong), 113, Yejik-ro, Cheoin-gu,  
Yongin-si, Gyeonggi-do, Korea  
Tel: +82-31-339-9970  
Fax: +82-31-624-9501

Report No.:  
CTK-2019-01366  
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## 1. Client

- Name : NEOLAB CONVERGENCE
- Address : #1501, Mario Tower, 28, Digital-ro 30-gil, Guro-gu, Seoul, Korea 08389
- Date of Receipt : 2019-03-19

## 2. Manufacturer

- Name : NEOLAB CONVERGENCE
- Address : #1501, Mario Tower, 28, Digital-ro 30-gil, Guro-gu, Seoul, Korea 08389

**3. Use of Report** : For FCC Certification & Canadian Certification

**4. Test Sample / Model**: Neo Smartpen / NWP-F51


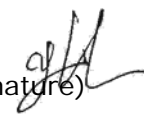
**5. Date of Test** : 2019-04-03 to 2019-04-12

**6. Test Standard(method) used** : FCC 47 CFR part 15 subpart C 15.247  
RSS-247, RSS-Gen

**7. Testing Environment**: Temp.: (21 ± 5) °C, Humidity: (50 ± 3) % R.H.

**8. Test Results** : Compliance

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This Test Report cannot be reproduced, except in full.

Affirmation	Tested by Bong-seok Kim: (Signature) 	Technical Manager Young-taek Lee: (Signature) 
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2019-04-12

Republic of KOREA **CTK Co., Ltd.**



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## REPORT REVISION HISTORY

Date	Revision	Page No
2019-04-12	Issued (CTK-2019-01366)	all

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## 1. General Product Description

### 1.1 Client Information

<b>Company</b>	NEOLAB CONVERGENCE
<b>Contact Point</b>	#1501, Mario Tower, 28, Digital-ro 30-gil, Guro-gu, Seoul, Korea 08389
<b>Contact Person</b>	Name : Cho Mingoo E-mail : mgcho@neolab.net Tel : +82-70-4377-0741 Fax : +82-2-3462-2983

### 1.2 Product Information

<b>FCC ID</b>	2AALG-NWP-F51
<b>IC</b>	21452-NWPF51
<b>Product Description</b>	Neo Smartpen
<b>Model name</b>	NWP-F51
<b>Operating Frequency</b>	2 402 MHz - 2 480 MHz
<b>RF Output Power</b>	0.37 dBm (1.089 mW)
<b>Antenna Specification</b>	Antenna type : Chip antenna Peak Gain : 2.9 dBi
<b>Number of channels</b>	40
<b>Channel Spacing</b>	2 MHz
<b>Type of Modulation</b>	GFSK
<b>Power Source</b>	DC 3.7 V
<b>Firmware Version Id Number(FVIN)</b>	REV. 1.0
<b>Test SW Version</b>	WCN_COMBO_TOOL
<b>RF Power setting in Test SW</b>	Initial value

### 1.3 Peripheral Devices





Device	Manufacturer	Model No.	Serial No.
Notebook	SAMSUNG Electronics	NT-R540	ZW3B93AZ900402F
AC Adapter	Tech-Power Electric Co.,Ltd.	NT01	09708530

## 2. Facility and Accreditations

### 2.1 Test Facility

The measurement facility is located at (Ho-dong), 113, Yejik-ro, Cheoin-gu, Yong-in-si, Gyeonggi-do, Korea.

### 2.2 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Registration Number	Logo
USA	FCC	FCC Part 15 & 18 EMI (Electromagnetic Interference / Emission)	805871	
CANADA	ISED	IC EMI (3/10m test site)	8737A-2	
JAPAN	VCCI	VCCI V-3 EMI (Electromagnetic Interference / Emission)	C-986 T-1843 R-3627 G-387	
KOREA	NRRA	EMI (Electromagnetic Interference / Emission) EMS (Electromagnetic Susceptibility / Immunity)	KR0025	

### 2.3 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.



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### 3. Test Specifications

#### 3.1 Standards

Section in FCC	Section in RSS	Requirement(s)	Status (Note 1)	Test Condition
15.247(a)	RSS-247 5.2(a)	6 dB Bandwidth	C	Conducted
15.247(e)	RSS-247 5.2(b)	Transmitter power spectral density	C	
15.247(b)	RSS-247 5.4(d)	Maximum peak conducted output power	C	
15.247(d)	RSS-247 5.5	Unwanted emission	C	
15.209	RSS-Gen 6.13	Transmitter emission	C	Radiated
15.207(a)	RSS-Gen 8.8	AC Conducted Emission	C	Line Conducted
<i>Note 1:</i> C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable				
<i>Note 2:</i> The data in this test report are traceable to the national or international standards.				
<i>Note 3:</i> The sample was tested according to the following specification: FCC Part 15.247, ANSI C63.10-2013, RSS-247 Issue 2, RSS-Gen Issue 5				
<i>Note 4:</i> The tests were performed according to the method of measurements prescribed in KDB No.558074.				

#### 3.2 Mode of operation during the test

The EUT is operated in a manner representative of the typical of the equipments.  
 During at testing, system components were manipulated within the confines of typical usage to maximize each emission. All modulation modes were tests.  
 The results are only attached worst cases.

##### Test Frequency

Lowest channel	Middle channel	Highest channel
2 402 MHz	2 440 MHz	2 480 MHz

##### Test mode

Modulation	Duty Cycle
GFSK	59.5%



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### 3.3 Maximum Measurement Uncertainty

The value of the measurement uncertainty for the measurement of each parameter.  
Coverage factor  $k = 2$ , Confidence levels of 95 %

Description	Uncertainty
Conducted RF Output Power	1.5 dB
Occupied Bandwidth	0.1 MHz
Unwanted Emission(conducted)	3.0 dB
Radiated Emissions ( $f \leq 1$ GHz)	4.0 dB
Radiated Emissions ( $f > 1$ GHz)	5.0 dB



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## 4. Technical Characteristic Test

### 4.1 6dB Bandwidth

#### Test Procedures(ANSI C63.10-2013 6.9.2)

Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

#### Test Procedures(ANSI C63.10-2013 6.9.3)

The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission.

Use the 99% power bandwidth function of the instrument and report the measured bandwidth.

#### Test Settings :

Center frequency = the highest, middle and the lowest channels

- a) RBW = 100 kHz
- b) VBW  $\geq 3 \times$  RBW
- c) Detector = peak
- d) Trace mode = Max hold
- e) Sweep = auto couple
- f) Allow trace to fully stabilize
- g) Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

#### **Limit :**

---

6 dB Bandwidth > 500kHz

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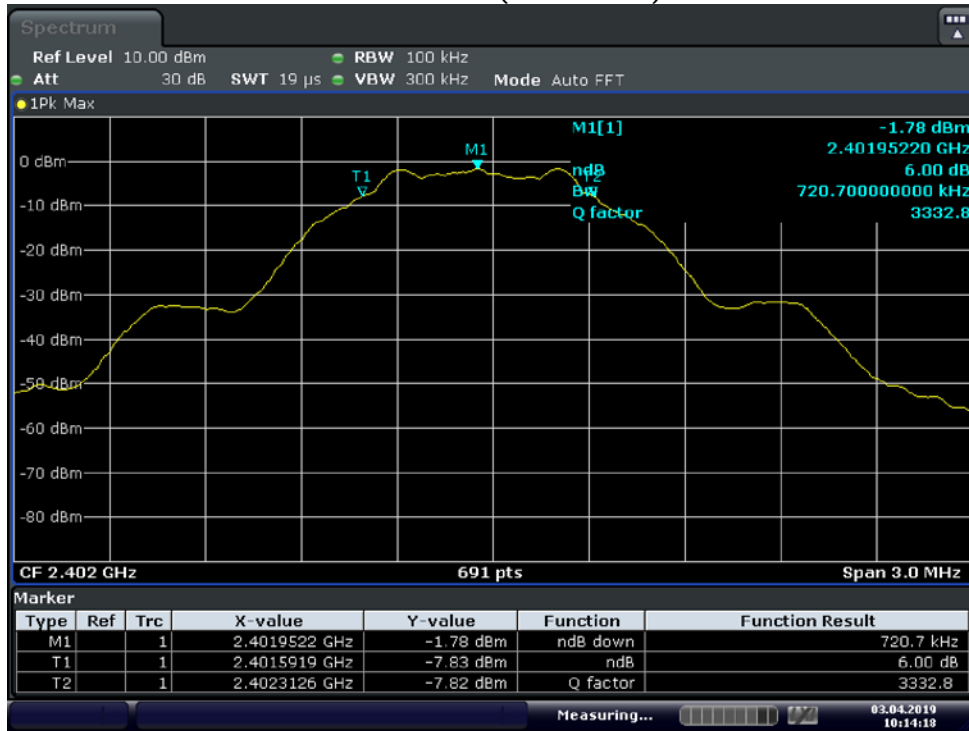
**Test Data :**

Channel	Frequency [MHz]	6 dB Bandwidth [MHz]	99% Bandwidth [MHz]	Result
Low	2 402	0.721	1.055	Complies
Middle	2 440	0.716	1.051	Complies
High	2 480	0.703	1.051	Complies

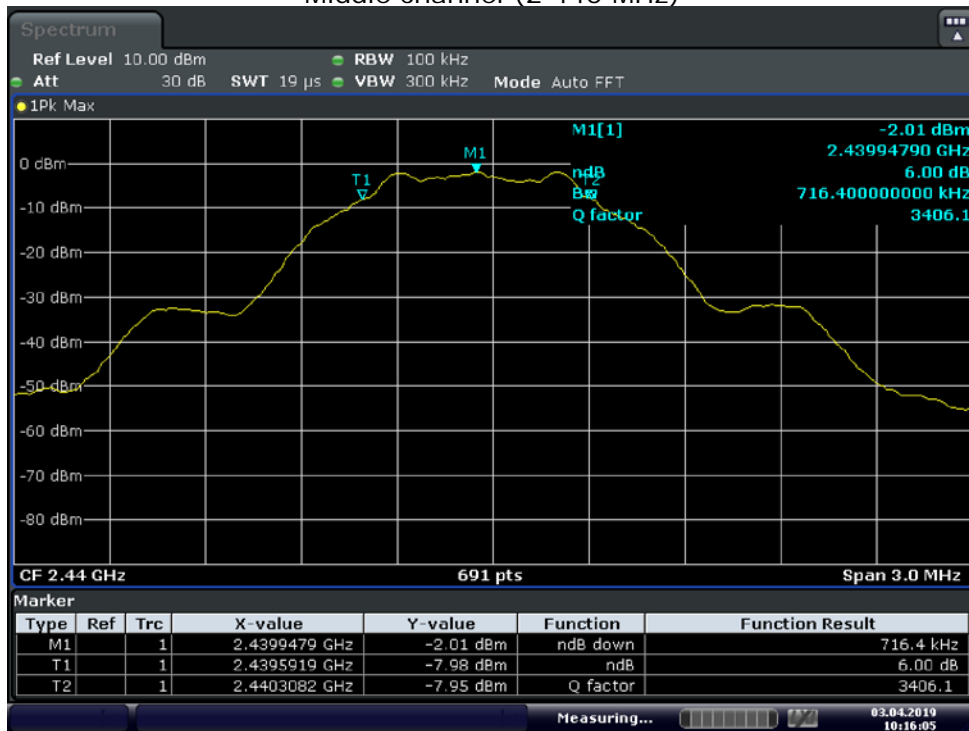
See next pages for actual measured spectrum plots.

## 6dB Bandwidth & 99% Bandwidth

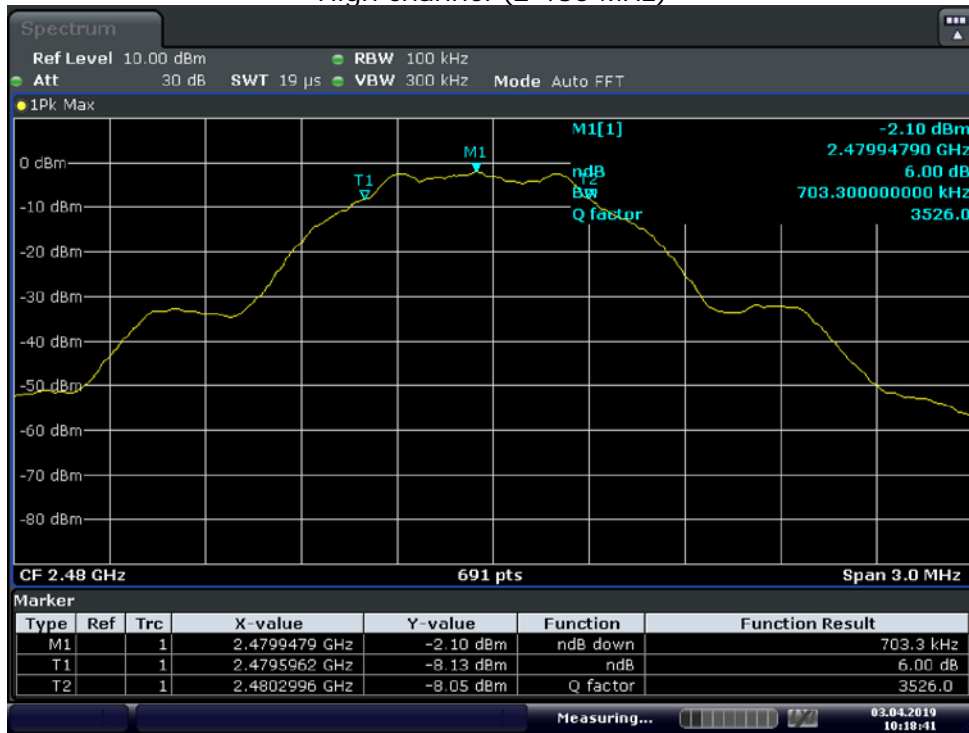
Low channel (2 402 MHz)



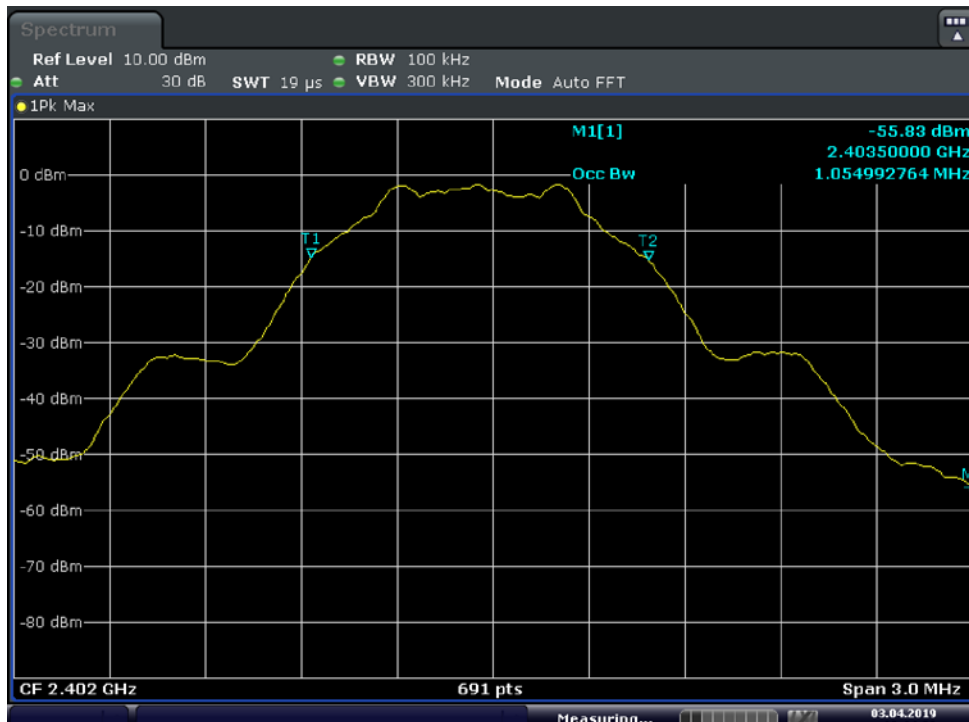
Middle channel (2 440 MHz)



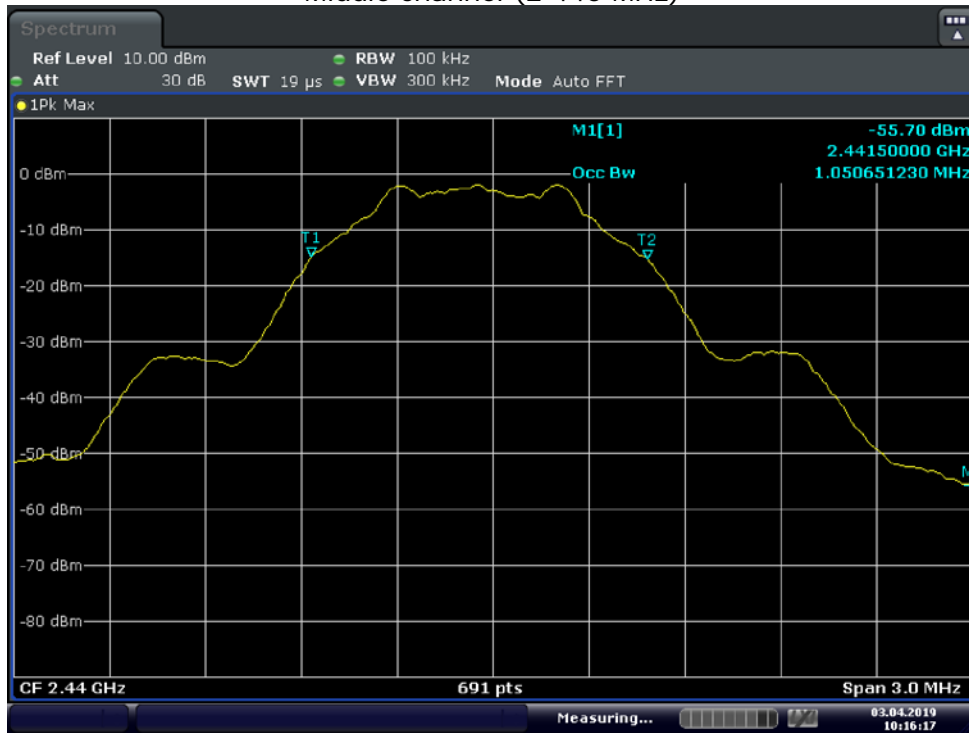
High channel (2 480 MHz)



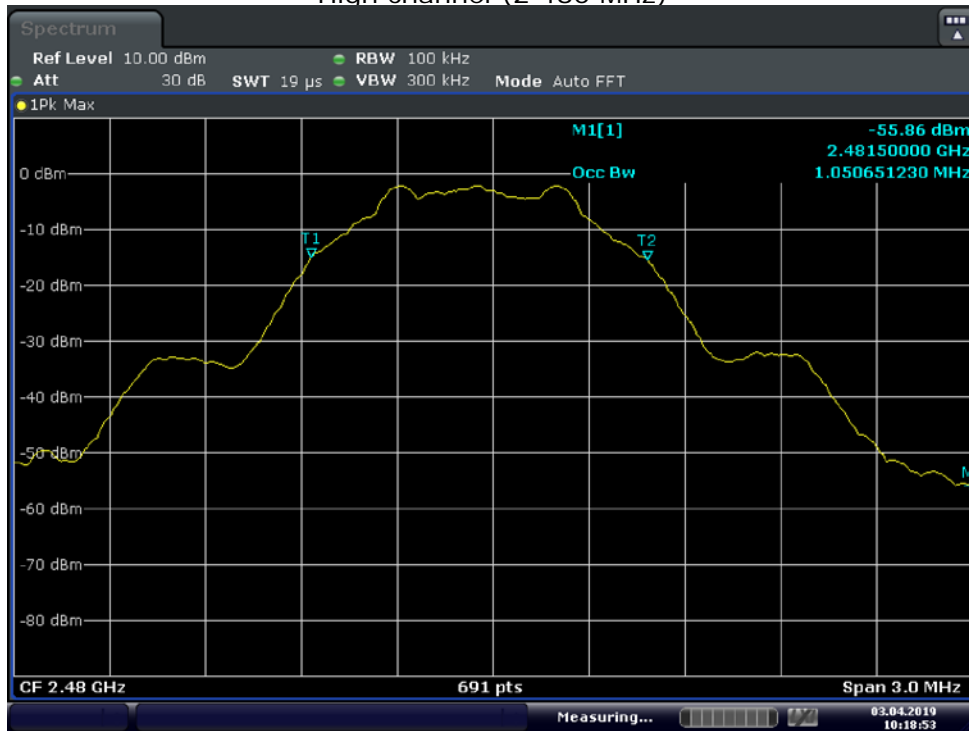
**99% Bandwidth**  
Low channel (2 402 MHz)



Middle channel (2 440 MHz)



High channel (2 480 MHz)





## 4.2 Maximum peak Conducted Output Power

### Test Procedures(ANSI C63.10-2013 11.9.1)

The following procedure can be used when the maximum available RBW of the instrument is less than the DTS bandwidth:

#### Test Settings:

Center frequency = the highest, middle and the lowest channels

- a)  $RBW \geq DTS \text{ Bandwidth}$
- b)  $VBW \geq 3 \times RBW$
- c)  $span \geq 3 \times RBW$
- d) Sweep time = auto couple
- e) Detector = peak
- f) Trace mode= max hold
- g) Allow trace to fully stabilize
- h) Use peak marker function to determine the peak amplitude level.

#### **Limit :**

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Maximum Output Power < 1 W (30 dBm)

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#### **Test Data :**

Channel	Frequency [MHz]	Measurement data [dBm]	Limit [dBm]	Result
Low	2 402	0.37	30	Complies
Middle	2 440	0.04	30	Complies
High	2 480	-0.05	30	Complies

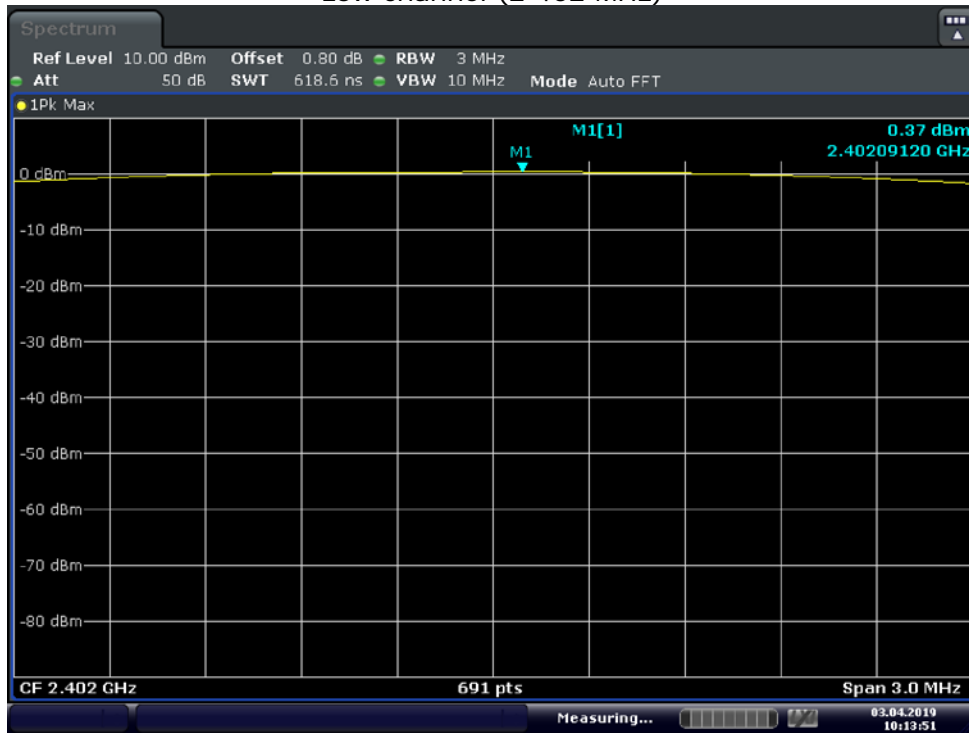
See next pages for actual measured spectrum plots.



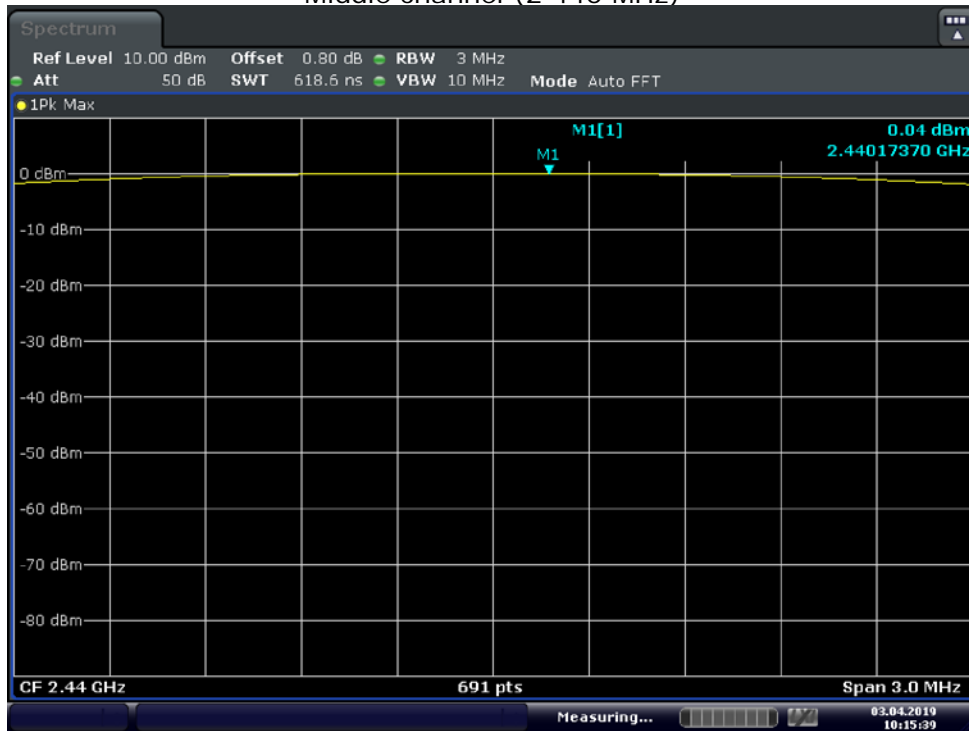
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Low channel (2 402 MHz)



Middle channel (2 440 MHz)

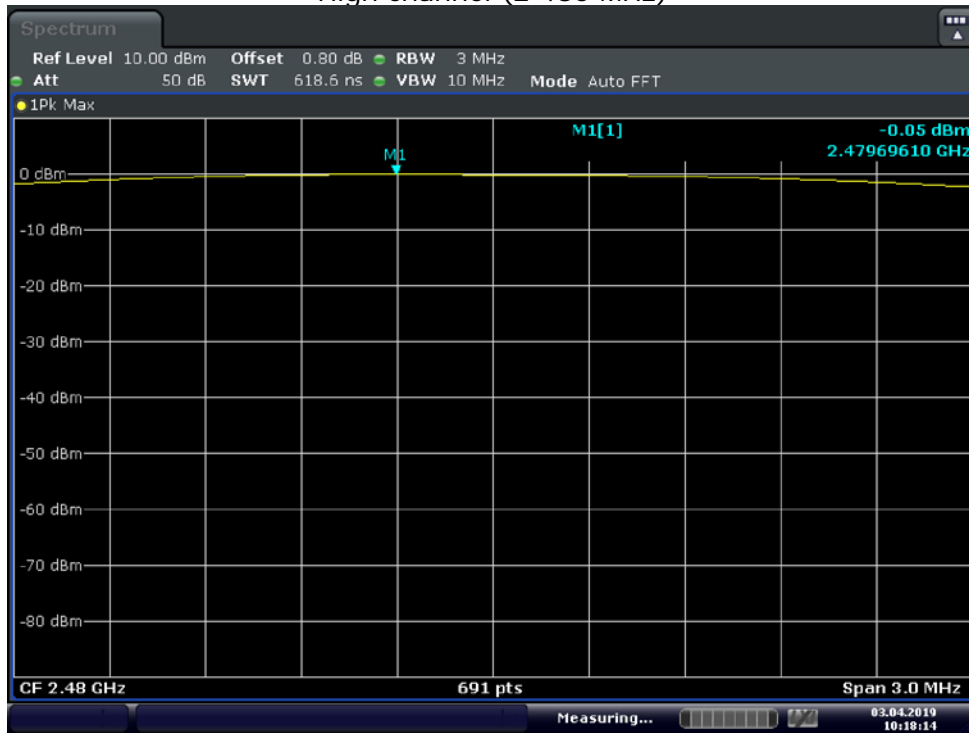




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### High channel (2 480 MHz)





### 4.3 Power Spectral Density

#### Test Procedures(ANSI C63.10-2013 11.10.2)

This procedure shall be used if maximum peak conducted output power was used to demonstrate compliance.

#### Test Settings:

Center frequency = the highest, middle and the lowest channels

- a) RBW :  $3 \text{ kHz} \leq \text{RBW} \leq 100 \text{ kHz}$
- b) VBW  $\geq 3 \times \text{RBW}$
- c) span  $\geq 1.5 \times \text{DTS bandwidth}$
- d) Sweep time = auto couple
- e) Detector = peak
- f) Trace mode= max hold
- g) Allow trace to fully stabilize
- h) Use the peak marker function to determine the maximum amplitude level within the RBW.

#### **Limit :**

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Power Spectral Density < 8 dBm @ 3 kHz BW

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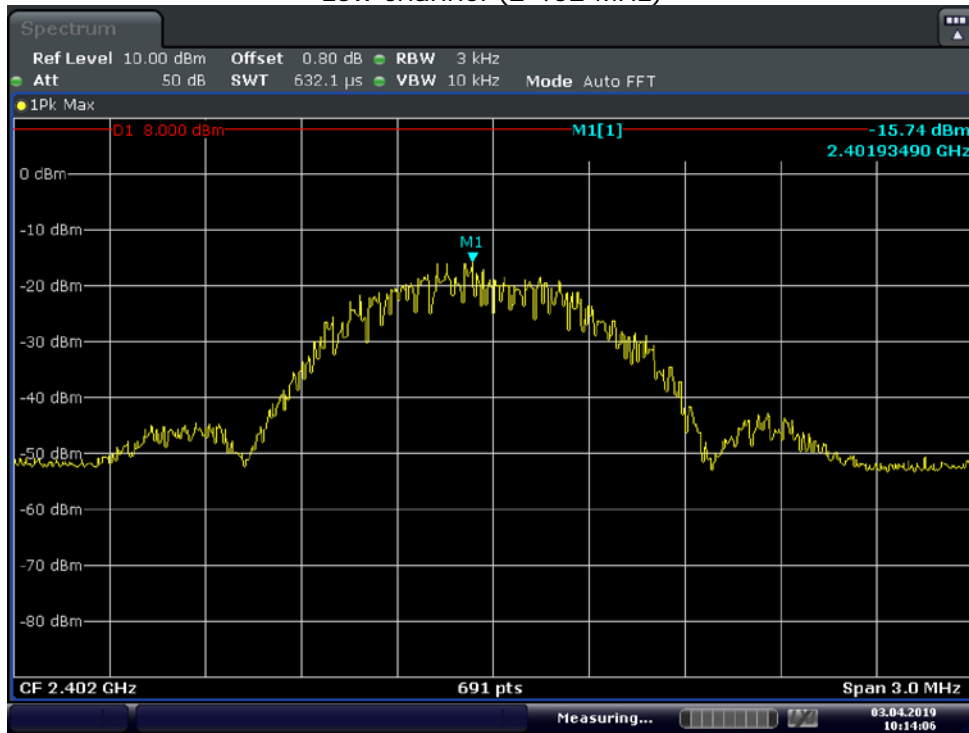
#### **Test Data :**

Channel	Frequency [MHz]	Measurement data [dBm]	Limit [dBm]	Result
Low	2 402	-15.74	8	Complies
Middle	2 440	-16.00	8	Complies
High	2 480	-16.13	8	Complies

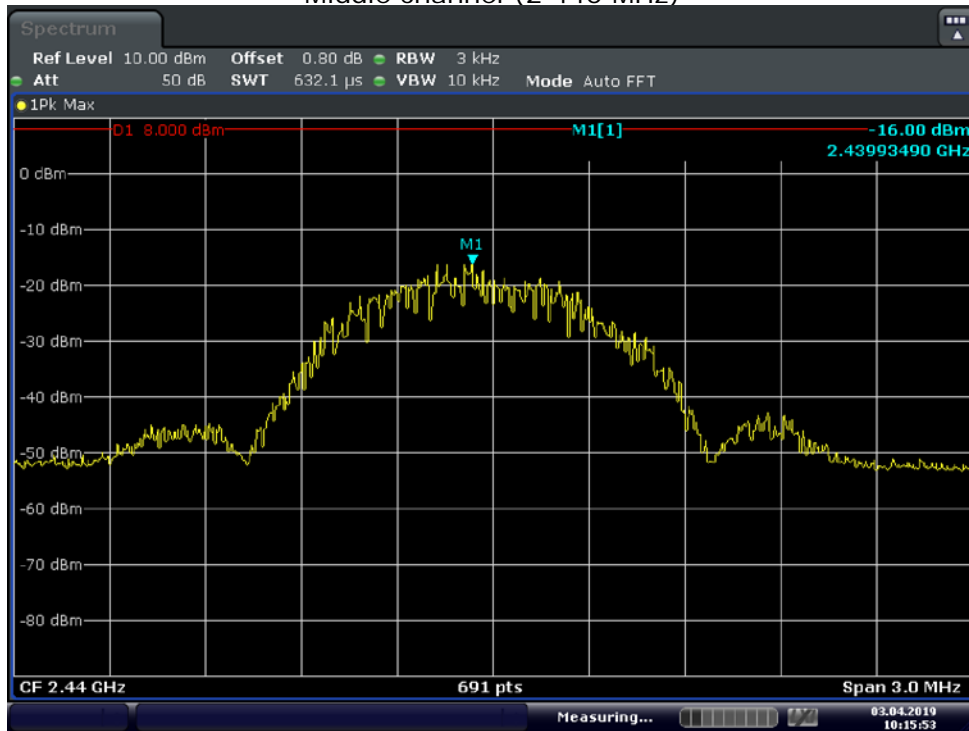
See next pages for actual measured spectrum plots.



Low channel (2 402 MHz)



Middle channel (2 440 MHz)

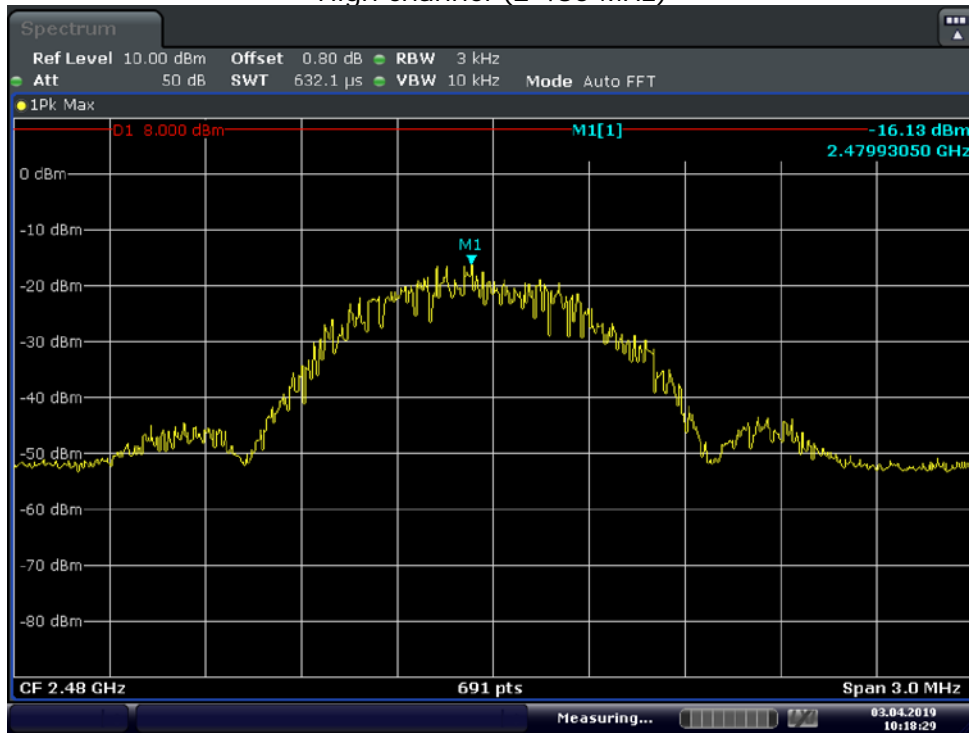




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### High channel (2 480 MHz)





## 4.4 Band Edge & Conducted Spurious emission

### Test Procedures(ANSI C63.10-2013 11.11.3)

The Unwanted emission from the EUT were measured according to the dictates PKPSD measurement procedure in section 11.11 of ANSI C63.10-2013.

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under Section 5.4(4), the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.

#### Test Settings:

Center frequency = the highest, middle and the lowest channels

- a) RBW = 100 kHz
- b) VBW  $\geq 3 \times$  RBW
- c) Detector = peak
- d) Sweep time = auto couple
- e) Trace mode= max hold
- f) Allow trace to fully stabilize
- g) Use the peak marker function to determine the maximum amplitude level.

#### **Limit :**

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Emission level < 20 dBc

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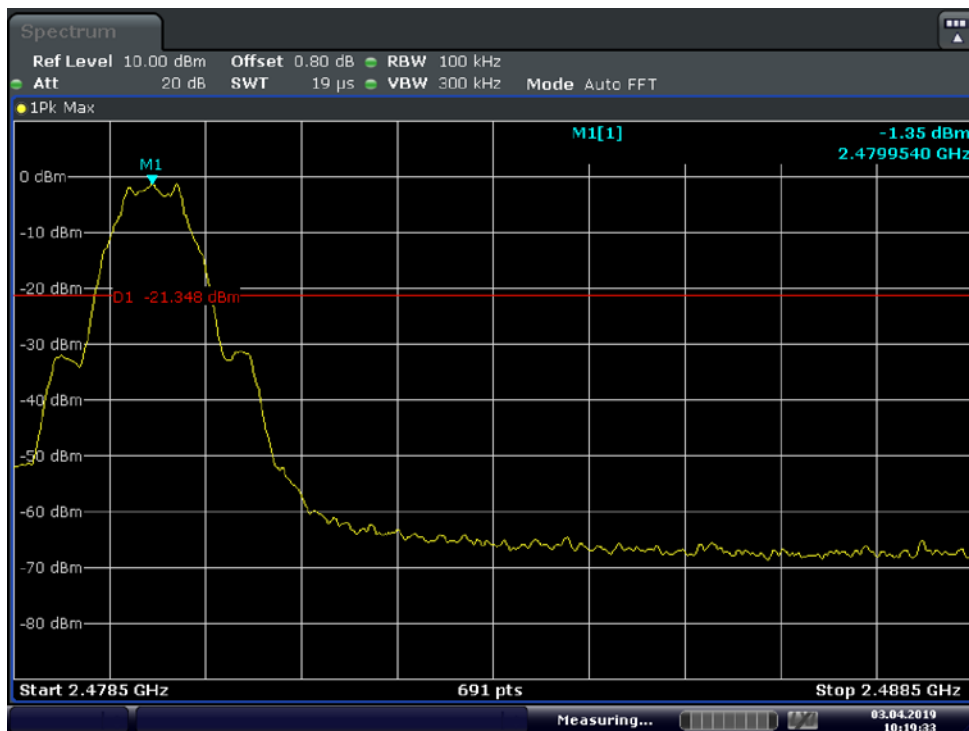
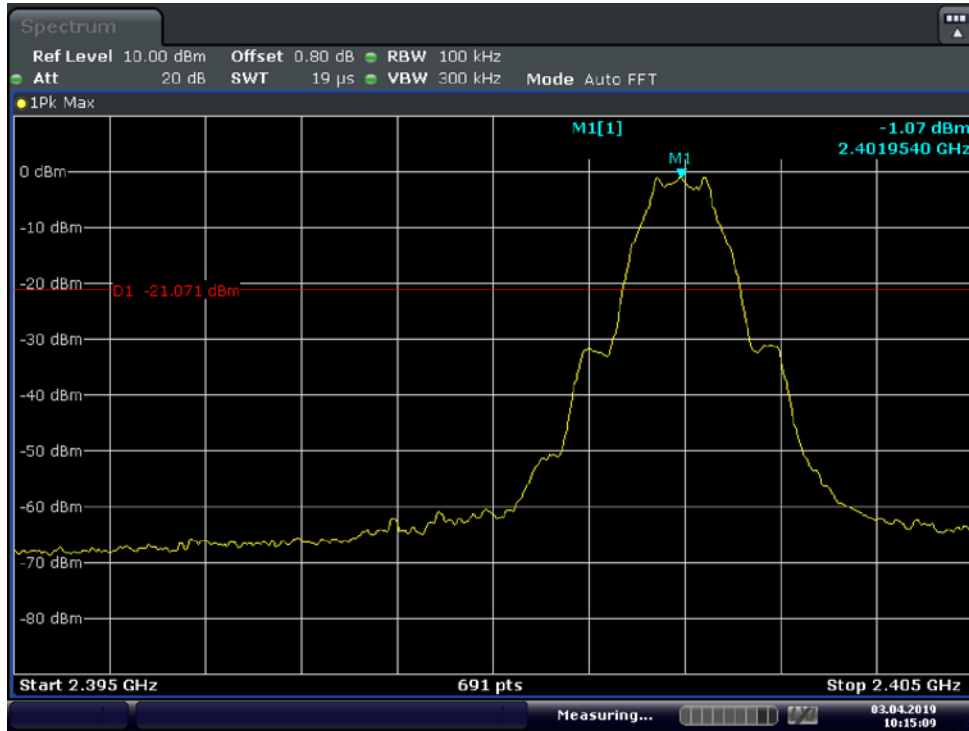
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#### **Test results: Complies**

- All conducted emission in any 100kHz bandwidth outside of the spread spectrum band was at least 20dB lower than the highest in-band spectral density. Therefore the applying equipment meets the requirement.

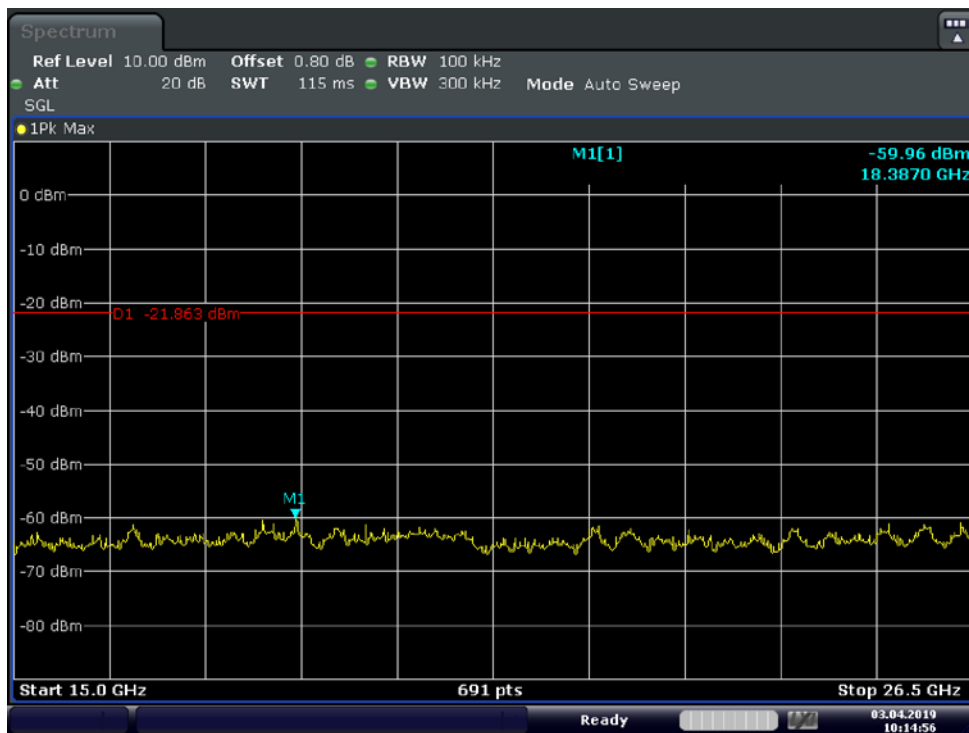
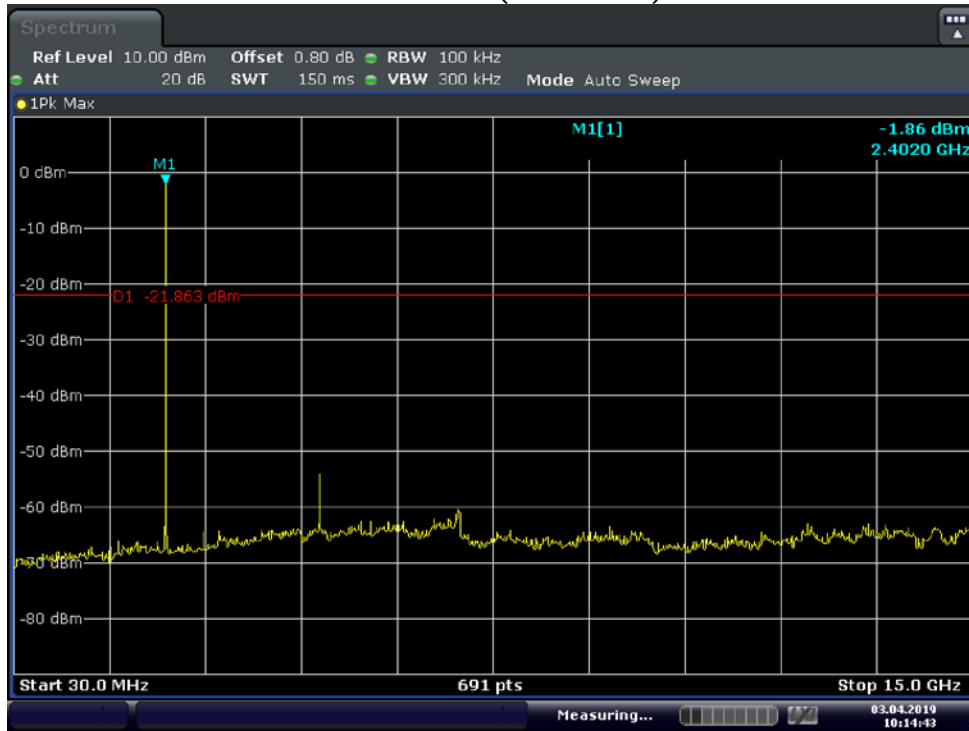
See next pages for actual measured spectrum plots.

### Band-edge



## Conducted Spurious emission

Low channel (2 402 MHz)

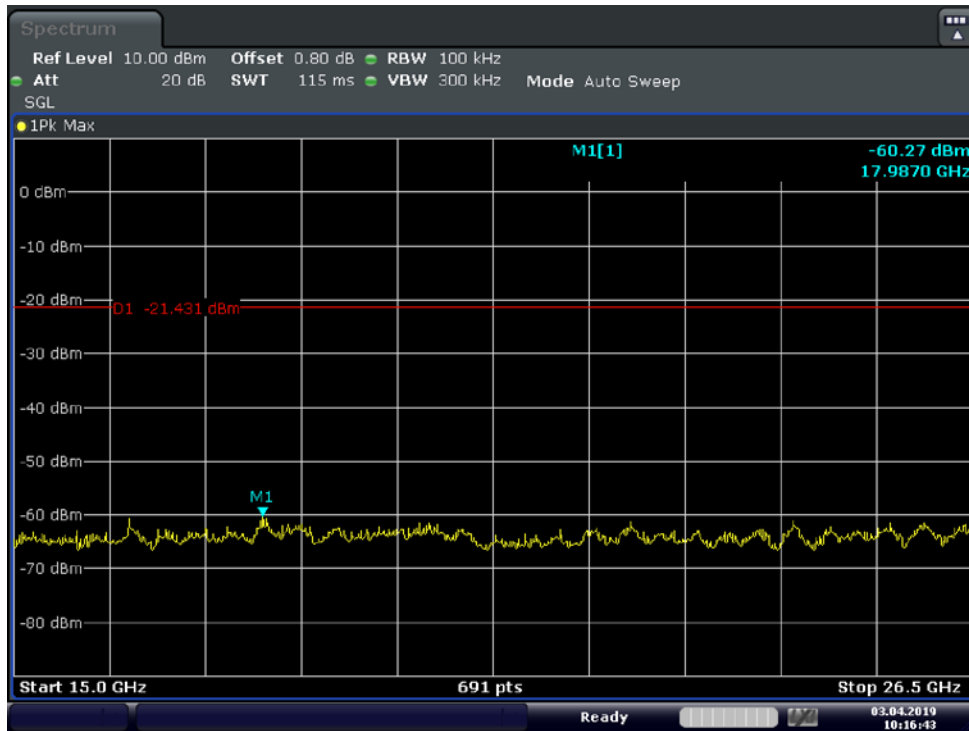
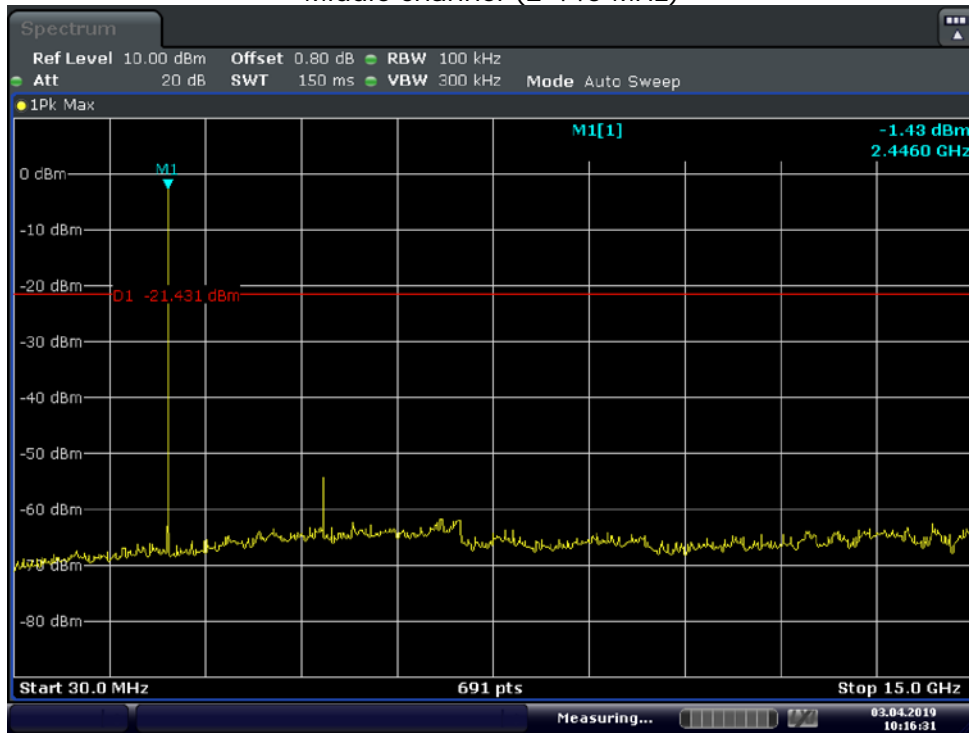




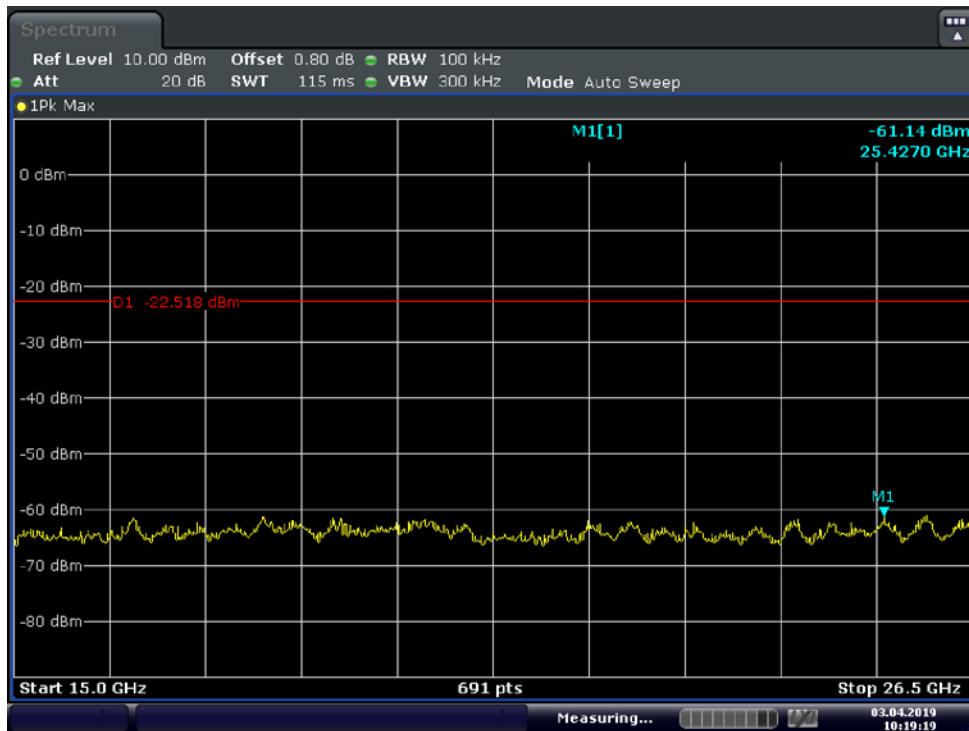
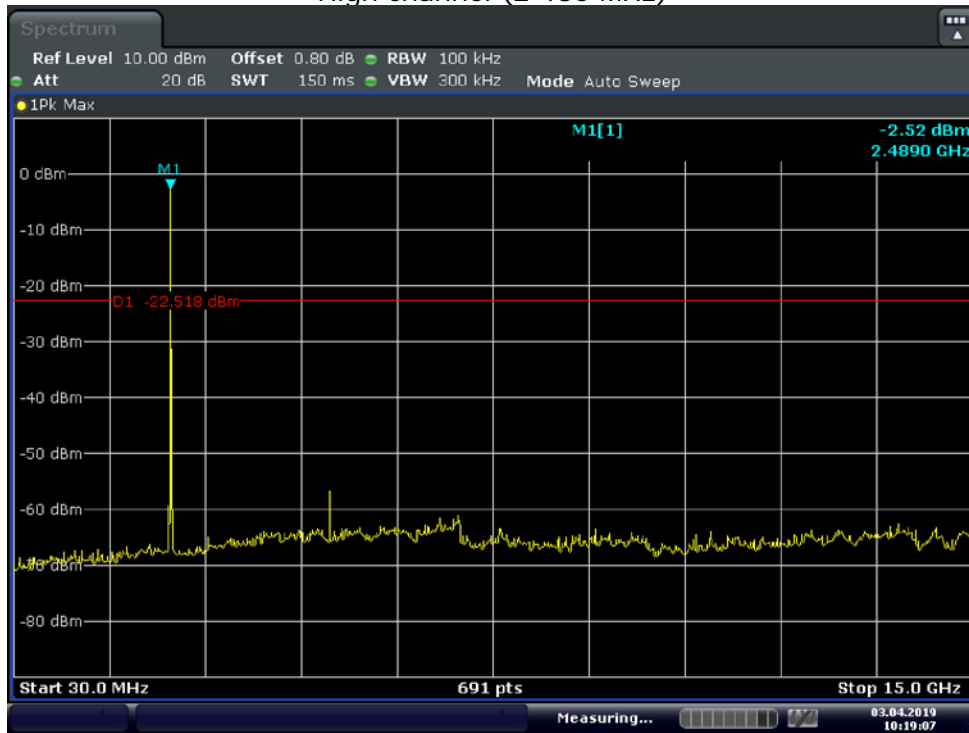
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Middle channel (2 440 MHz)



High channel (2 480 MHz)





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## 4.5 Radiated Emission

### Test Location

- 10 m SAC (test distance :  10 m,  3 m)  
 3 m SAC (test distance : 3 m)

### Test Procedures

- 1) In the frequency range of 9 kHz to 30 MHz, magnetic field is measured with Loop Antenna. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.
- 2) In the frequency range above 30 MHz, Bi-Log Test Antenna(30 MHz to 1 GHz) and Horn Test Antenna(above 1 GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is carried from 1m to 4m above the ground to determine the maximum value of the field strength. The emissions levels at both horizontal and vertical polarizations should be tested.

### Instrument Settings

Frequency Range = 9 kHz ~ 25 GHz (2.4 GHz 10<sup>th</sup> harmonic)

- a) RBW = 1 MHz for  $f \geq 1$  GHz, 100 kHz for  $f < 1$  GHz, 9 kHz for  $f < 30$  MHz
- b) VBW  $\geq$  RBW
- c) Sweep time = auto couple





**Limit :**

Unwanted emissions that do not fall within the restricted frequency bands of Table 1 shall comply either with the limits specified in the applicable RSS or with those specified in this RSS-Gen.

FCC Part 15 § 15.205 (a) Except as shown in paragraph (d) of this section, only spurious emissions are permitted in any of the frequency bands listed below:

**Table 1. Restricted Frequency Bands**

MHz	MHz	MHz	MHz	MHz	GHz
0.09-0.11	8.37626-8.38675	73-74.6	399.9-410	2690-2900	10.6-12.7
<sup>1</sup> 0.495-0.505	8.41425-8.41475	74.8-75.2	608-614	3260-3267	13.25-13.4
2.1735-2.1905	12.29-12.293	108-121.94	960-1240	3332-3339	14.47-14.5
4.125-4.128	12.51975-12.52025	123-138	1300-1427	3345.8-3358	15.35-16.2
4.17725-4.17775	12.57675-12.57725	149.9-150.05	1435-1626.5	3600-4400	17.7-21.4
4.20725-4.20775	13.36-13.41	156.52475-156.52525	1645.5-1646.5	4500-5150	22.01-23.12
6.215-6.218	16.42-16.423	156.7-156.9	1660-1710	5350-5460	23.6-24
6.26775-6.26825	16.69475-16.69525	162.0125-167.17	1718.8-1722.2	7250-7750	31.2-31.8
6.31175-6.31225	16.80425-16.80475	167.72-173.2	2200-2300	8025-8500	36.43-36.5
8.291-8.294	25.5-25.67	240-285	2310-2390	9000-9200	<sup>2</sup> Above 38.6
8.362-8.366	37.5-38.25	322-335.4	2483.5-2500	9300-9500	

<sup>1</sup> Until February 1, 1999, this restricted band shall be 0.490-0.510 MHz.

<sup>2</sup> Above 38.6

§ 15.205 (b) Except as provided in paragraphs (d) and (e), the field strength of emissions appearing within these frequency bands shall not exceed the limits shown in Section 15.209. At frequencies equal to or less than 1000 MHz, compliance with the limits in Section 15.209 shall be demonstrated using measurement instrumentation employing a CISPR quasi-peak detector. Above 1000 MHz, compliance with the emission limits in Section 15.209 shall be demonstrated based on the average value of the measured emissions. The provisions in Section 15.35 apply to these measurements.



FCC Part 15 § 15.209 (a) Except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table :

Except when the requirements applicable to a given device state otherwise, emissions from licence-exempt transmitters shall comply with the field strength limits shown in Table 2. Additionally, the level of any transmitter emission shall not exceed the level of the transmitter's fundamental emission.

**Table 2. General Field Strength Limits for Licence-Exempt Transmitters**

Frequency(MHz)	Field Strength uV/m@3m	Field Strength dBuV/m@3m	Measurement Distance (meters)
0.009-0.490	2400/F(kHz)	-	300
0.490-1.705	24000/F(kHz)	-	30
1.705-30	30	-	30
30-88	100**	40	3
88-216	150**	43.5	3
216-960	200**	46	3
Above 960	500	54	3

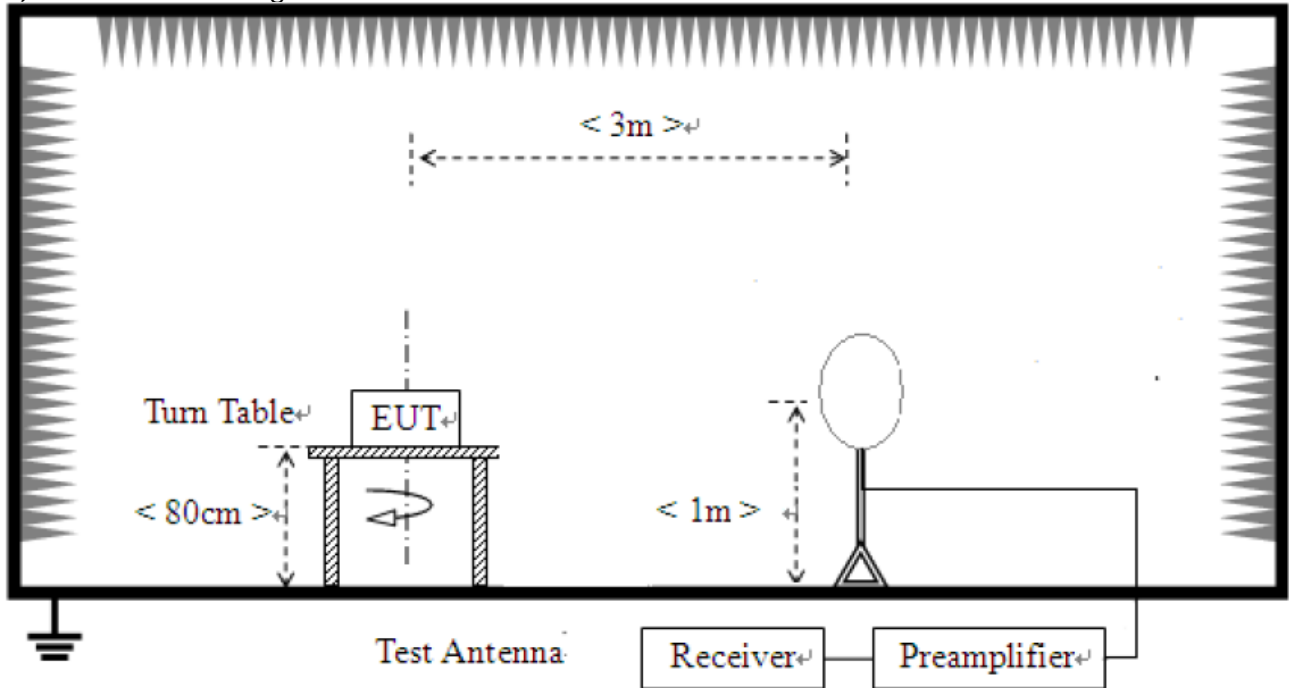
\*\* Except as provided in 15.209(g).fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54-72MHz, 76-88MHz, 174-216MHz, 470-806MHz. However, operation within these frequency bands is permitted under other sections of this Part, e.g.15.231 and 15.241.

Note :

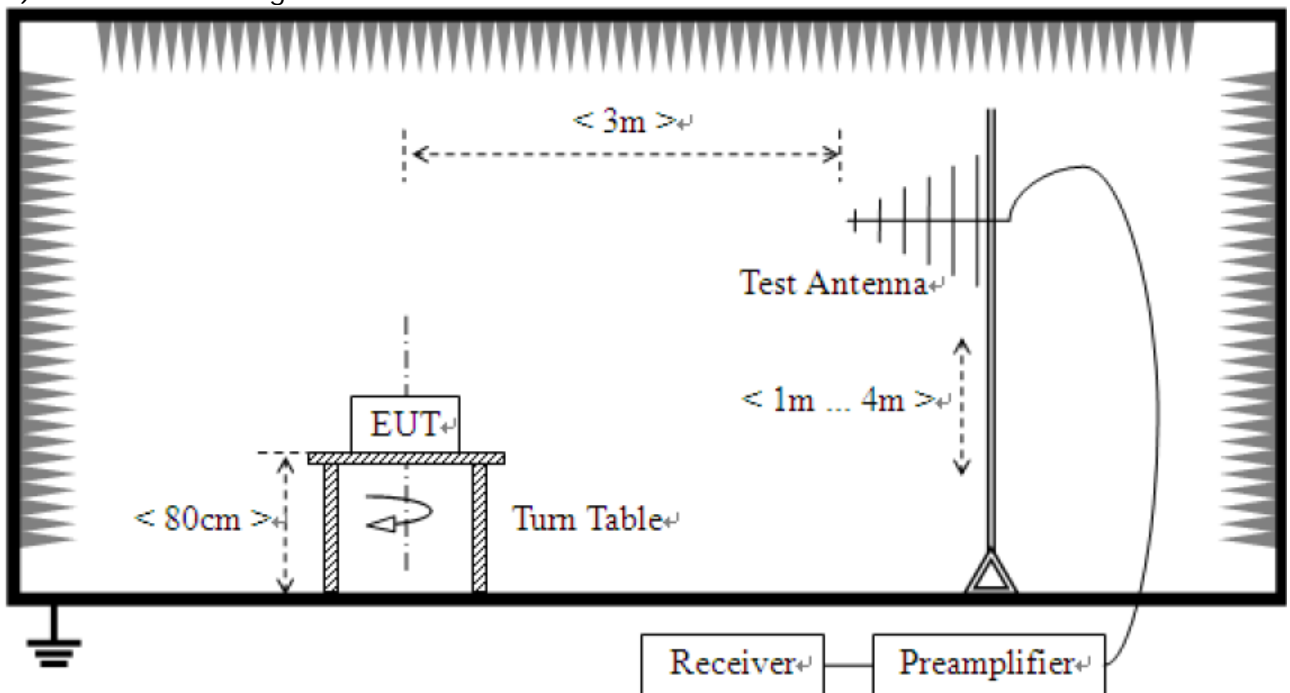
- 1) For above 1 GHz, the emission limit in this paragraph is based on measurement instrumentation employing an average detector, measurement using instrumentation with a peak detector function, corresponding to 20 dB above the maximum permitted average limit.
- 2) For above 1 GHz, limit field strength of harmonics : 54 dBuV/m@3m (AV) and 74 dBuV/m@3m (PK)

**Test Setup:**

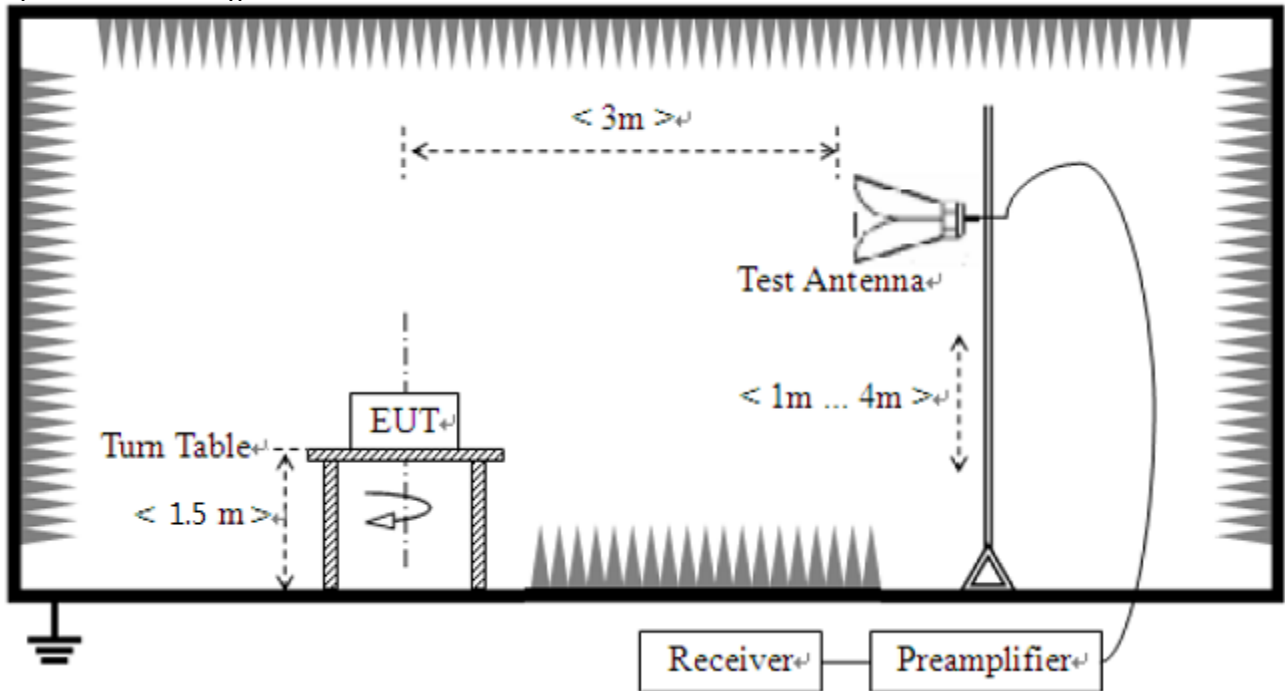
- 1) For field strength of emissions from 9 kHz to 30 MHz



- 2) For field strength of emissions from 30 MHz to 1 GHz



3) For field strength of emissions above 1 GHz



## Test results

### 1) 9 kHz to 30 MHz

The requirements are:

Complies

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
-	-	-	See note

#### Note :

The amplitude of spurious emissions that are attenuated by more than 20 dB below the permissible value has no need to be reported.

Distance extrapolation factor =  $40 \log (\text{specific distance} / \text{test distance})$  (dB)

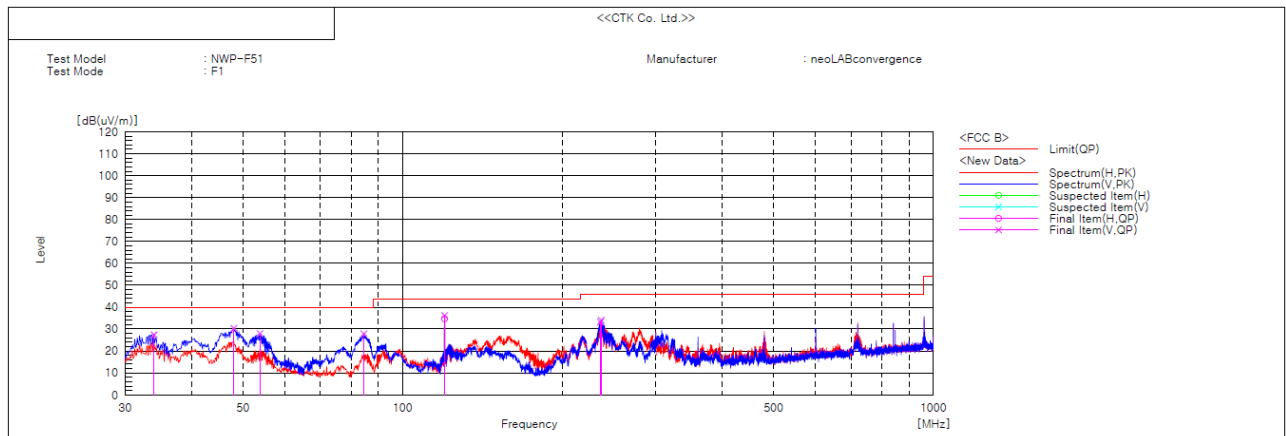
## 2) 30 MHz to 1 GHz

Test mode : High Channel(Worst case)

The requirements are:

Complies

### Test Data



No.	Frequency [MHz]	(P)	Reading [dB(uV)]	c.f [dB(1/m)]	Result PK [dB(uV/m)]	Limit QP [dB(uV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]	Remark
1	34.028	V	42.4	-15.0	27.4	40.0	12.6	99.8	303.3	
2	48.072	V	42.8	-12.4	30.4	40.0	9.6	99.8	23.2	
3	53.842	V	40.6	-12.6	28.0	40.0	12.0	99.8	316.4	
4	84.543	V	45.5	-17.6	27.9	40.0	12.1	99.8	350.7	
5	119.925	V	52.0	-15.8	36.2	43.5	7.3	99.8	23.2	
6	119.925	H	50.5	-15.8	34.7	43.5	8.8	99.8	318.1	
7	235.869	V	46.6	-13.3	33.3	46.0	12.7	99.8	226.4	
8	236.631	V	47.4	-13.3	34.1	46.0	11.9	99.8	235.7	

### Remark :

1. The Unwanted emission was measured in the following position: EUT stand-up position(Z axis), lie-down position(X,Y axis). The worst emission was found in lie-down position(X axis) and the worst case was recorded.
2. Result = Reading + c.f(Correction factor)
3. Correction factor = Antenna factor + Cable loss + 6 dB attenuator - Amp Gain
4. This data is the Peak(PK) value.



### 3) 1 GHz to 25 GHz

The requirements are:

Complies

#### Test Data

##### Test mode : Lowest frequency(2 402 MHz)

Frequency [MHz]	Ant. Pol. (V/H)	Reading* [dBuV/m]	c.f [dB/m]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
1 919.7	H	48.10	-4.00	<b>44.10</b>	54	9.90	Peak

##### Test mode : Middle frequency(2 440 MHz)

Frequency [MHz]	Ant. Pol. (V/H)	Reading* [dBuV/m]	c.f [dB/m]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
1 919.7	H	49.60	-4.00	<b>45.60</b>	54	8.40	Peak

##### Test mode : Highest frequency(2 480 MHz)

Frequency [MHz]	Ant. Pol. (V/H)	Reading* [dBuV/m]	c.f [dB/m]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
1 919.7	H	48.30	-4.00	<b>44.30</b>	54	9.70	Peak

#### Remarks

1. The Unwanted emission was measured in the following position: EUT stand-up position(Z axis), lie-down position(X,Y axis). The worst emission was found in lie-down position(X axis) and the worst case was recorded.
  2. Result = Reading + c.f(correction factor)
  3. Correction factor = Antenna factor + Cable loss - Amp Gain
- \* Reading data is the peak value.



## 4.6 AC Power Line Conducted Emissions

A radio apparatus that is designed to be connected to the public utility (AC) power line shall ensure that the radio frequency voltage, which is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz-30 MHz, shall not exceed the limits.

### Instrument Settings

IF Band Width: 9 kHz

### Test Procedures

The EUT was placed on a non-metallic table 0.8m above the metallic, grounded floor and 0.4m from the reference ground plane wall. The distance to other metallic surfaces was at least 0.8m.

Amplitude measurements were performed with a quasi-peak detector and an average detector.

### Limit

Frequency (MHz)	Conducted Limit (dBuV)	
	Quasi-peak	Average**
0.15 ~ 0.5	66 to 56*	56 to 46*
0.5 ~ 5	56	46
5 ~ 30	60	50

\* The level decreases linearly with the logarithm of the frequency.

\*\* A linear average detector is required.

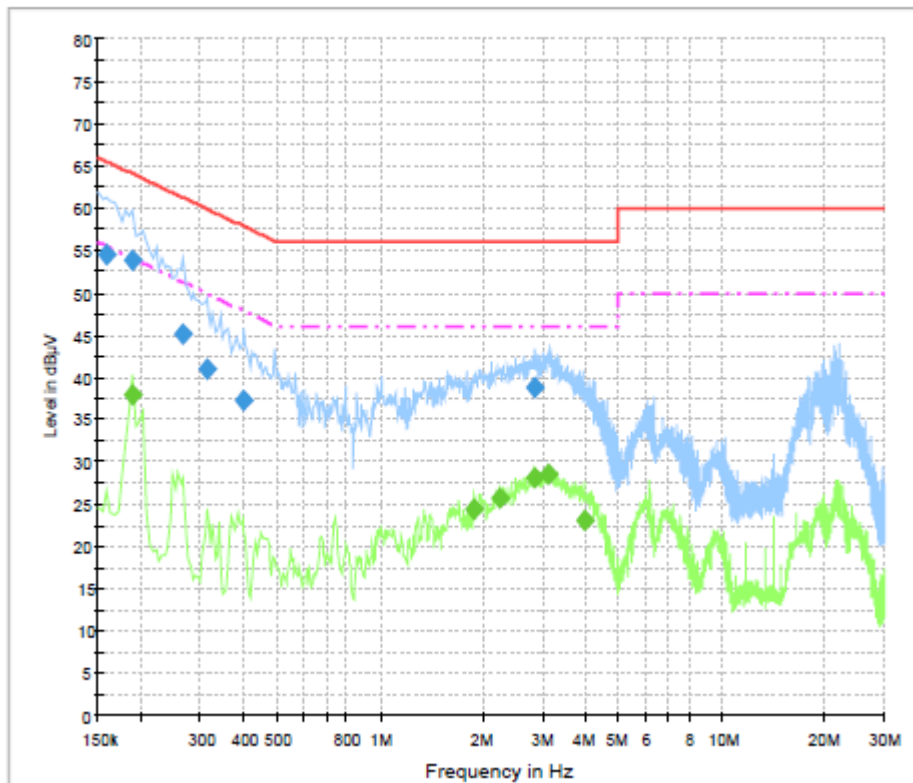
## Test Results

The requirements are:

Complies

## Test Data

Test mode : Charging Mode  
[L1]  
Class B\_L1



### Final Result 1

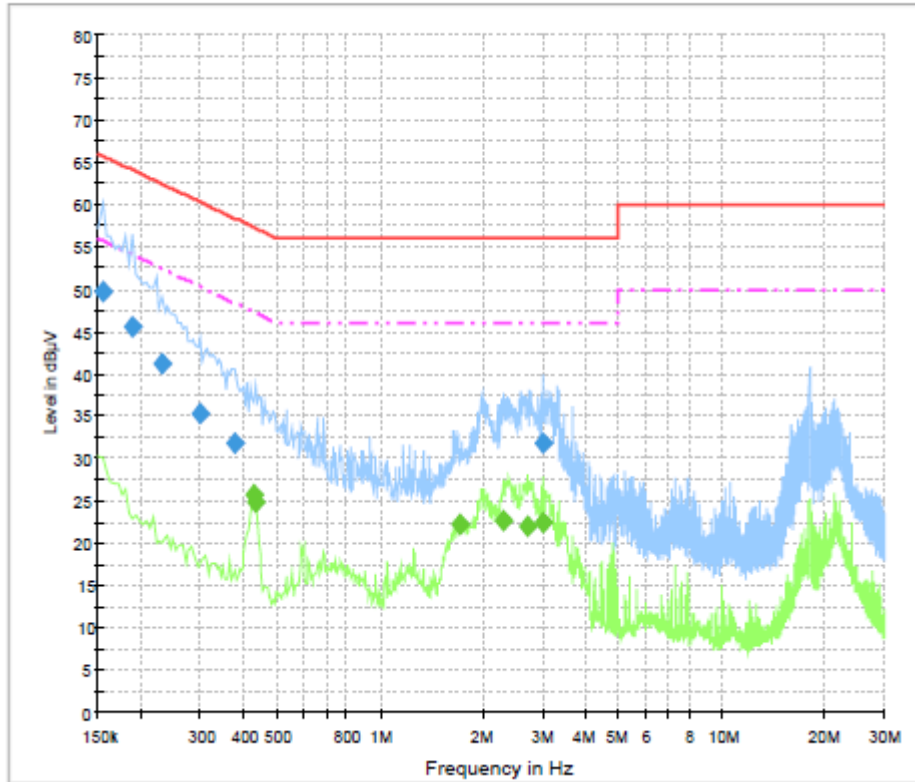
Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.159000	54.5	1000.0	9.000	On	L1	10.2	11.0	65.5
0.190500	53.9	1000.0	9.000	On	L1	10.2	10.2	64.0
0.267000	45.2	1000.0	9.000	On	L1	10.0	16.0	61.2
0.312000	41.0	1000.0	9.000	On	L1	10.0	18.9	59.9
0.402000	37.3	1000.0	9.000	On	L1	10.1	20.5	57.8
2.854500	38.8	1000.0	9.000	On	L1	10.0	17.2	56.0

### Final Result 2

Frequency (MHz)	CAverage (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.190500	38.0	1000.0	9.000	On	L1	10.2	16.0	54.0
1.896000	24.3	1000.0	9.000	On	L1	9.9	21.7	46.0
2.251500	25.8	1000.0	9.000	On	L1	10.0	20.2	46.0
2.854500	28.2	1000.0	9.000	On	L1	10.0	17.8	46.0
3.106500	28.5	1000.0	9.000	On	L1	10.0	17.5	46.0
3.993000	23.0	1000.0	9.000	On	L1	10.0	23.0	46.0



**[NEUTRAL]**  
Class B\_N



**Final Result 1**

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.154500	49.7	1000.0	9.000	On	N	10.4	16.1	65.8
0.190500	45.5	1000.0	9.000	On	N	10.5	18.5	64.0
0.231000	41.3	1000.0	9.000	On	N	10.3	21.1	62.4
0.298500	35.4	1000.0	9.000	On	N	10.3	24.9	60.3
0.375000	31.7	1000.0	9.000	On	N	10.5	26.7	58.4
3.007500	31.7	1000.0	9.000	On	N	10.3	24.3	56.0

**Final Result 2**

Frequency (MHz)	CAverage (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.429000	25.8	1000.0	9.000	On	N	10.5	21.4	47.3
0.433500	24.8	1000.0	9.000	On	N	10.5	22.4	47.2
1.711500	22.2	1000.0	9.000	On	N	10.3	23.8	46.0
2.296500	22.6	1000.0	9.000	On	N	10.3	23.4	46.0
2.710500	21.9	1000.0	9.000	On	N	10.3	24.1	46.0
3.007500	22.5	1000.0	9.000	On	N	10.3	23.5	46.0



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Report No.:  
 CTK-2019-01366  
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## APPENDIX A – Test Equipment Used For Tests

No.	Name of Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Due Date
1	Signal Analyzer	R&S	FSV30	100925	2019-01-21	2020-01-21
2	Signal Generator	Rohde & Schwarz	SMB100A	175528	2018-10-24	2019-10-24
3	DC Power Supply	Agilent	E3632A	MY40011638	2018-10-24	2019-10-24
4	EMI Test Receiver	Rohde & Schwarz	ESCI7	100814	2018-10-25	2019-10-25
5	Bilog Antenna	Schaffner	CBL6111C	2551	2018-05-10	2020-05-10
6	Active Loop Antenna	SCHWARZBECK	FMZB 1513	1513-125	2018-05-02	2020-05-02
7	6dB Attenuator	R&S	DNF	272.4110.50-2	2018-10-25	2019-10-25
8	AMPLIFIER	SONOMA	310	291721	2019-01-28	2020-01-28
9	EMI Test Receiver	Rohde & Schwarz	ESU40	100336	2019-01-29	2020-01-29
10	Preamplifier	Agilent	8449B	3008A02011	2018-12-03	2019-12-03
11	Horn Antenna	ETS-Lindgren	3117	00154525	2017-09-14	2019-09-14
12	Horn Antenna	ETS-Lindgren	3116	00062916	2017-04-25	2019-04-25

No.	Name of Equipment	Manufacturer	Model No.	Serial No.	Check Date
1	RF Cable (conducted)	Junkosha Inc.	MWX221	1510S087	2019-02-02
2	RF Cable (Radiated)	HUBER+SUHNER	SUCOFLEX 104	MY27558/4	2019-02-02
3	RF Cable (Radiated)	HUBER+SUHNER	SUCOFLEX 104	N/A (below 1GHz)	2019-02-02
4	RF Cable (Radiated)	HUBER+SUHNER	SUCOFLEX 104	MY27573/4	2018-11-30
5	RF Cable (Radiated)	HUBER+SUHNER	SUCOFLEX 106	N/A (above 1GHz)	2018-11-30

## APPENDIX B – EUT Photographs

